

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/807,959	BARTON ET AL.	
Examiner	Art Unit	
John L. Shew	2664	

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	203-204	3/8/2006	JS
	206-208		
	210,252		
	343,350		
	470,478		
	480,482		
	503,504		
	509,519		
	520,528		
375	116,129	3/8/2006	JS
	131,141		
	147,150		
	219,220		
	267,298		

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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09/807,959	BARTON ET AL.
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	SEAR	CHED	
Class	Subclass	Date	Examiner
375	341,343	3/8/2006	JS
	354-376		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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